

Associated clusters analysis @ TB PS202205

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Szymon Bugiel, Andrei Dorokhov, Serhiy Senyukov, **Yitao WU**

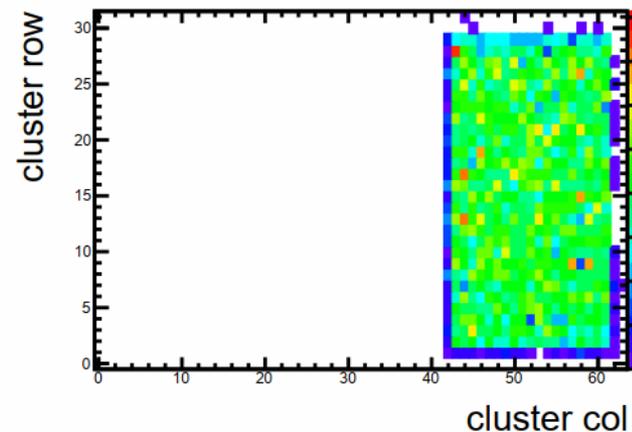
2022.06.15





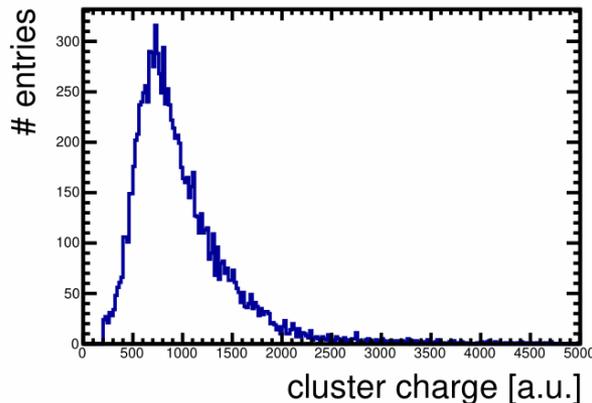
- B4 HV=10V, PSUB=0V
- Sub-matrix: SF
 - Seeding
 - seed SNR > 2
 - cluster charge > 200
 - method: sum3x3
 - Sensor edge: 2 pixel

Map of associated clusters

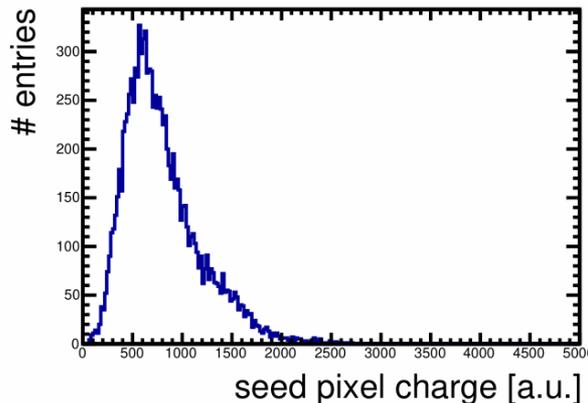


WORK IN PROGRESS

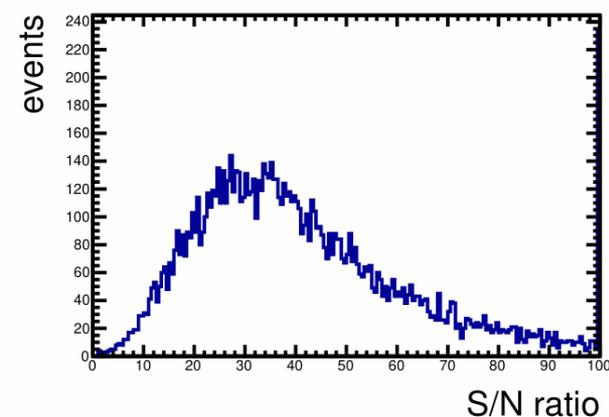
Charge distribution of associated clusters



Charge distribution of seed pixels for associated clusters



CE65_4 Cluster seed S/N





- B4 HV=10V, PSUB=0V
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Raw efficiency : $96.5^{+0.2}_{-0.2}$ %

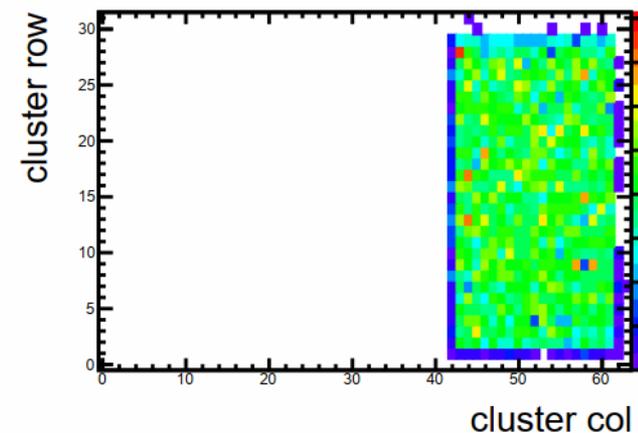
All tracks N_{trk} : 46385

- $\chi^2 / \text{Ndf} > 3$: -1223
- outside DUT : -9709
- outside ROI : -23949
- close to mask : -1223

Track pass selectoin : 11504

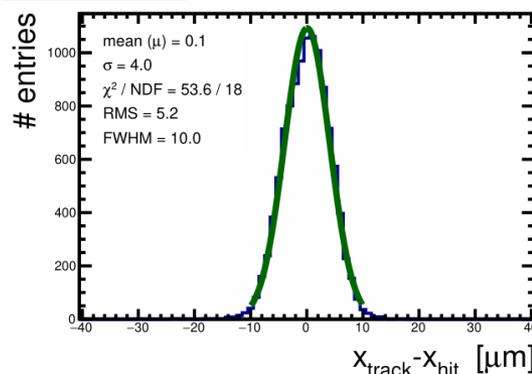
Associated clusters $N_{\text{assoc. cls.}}$: 11103

Map of associated clusters

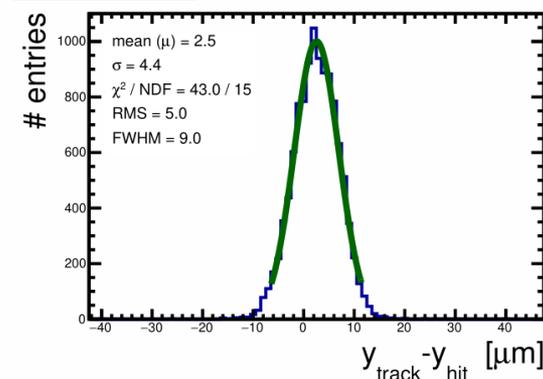


WORK IN PROGRESS

Residual in global X

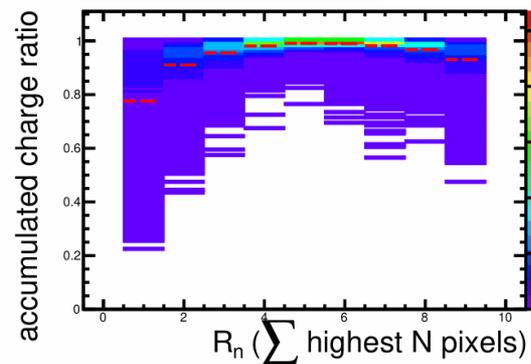


Residual in global Y

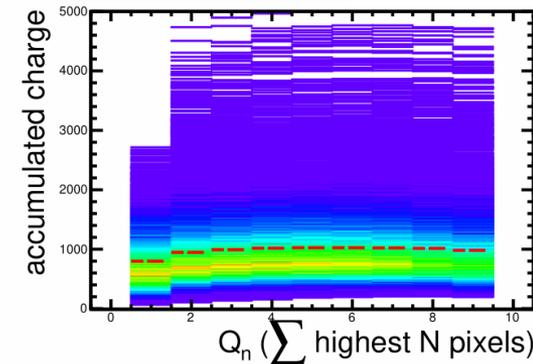


- B4 HV=10V, PSUB=0V
 - Sub-matrix: SF
- Cluster shape
 - count all neighbours
 - ratio = $\frac{px. charge}{max. charge}$

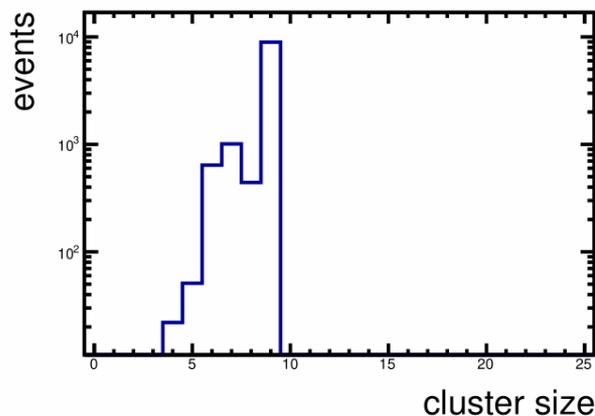
CE65_4 Cluster total charge ratio in N pixels



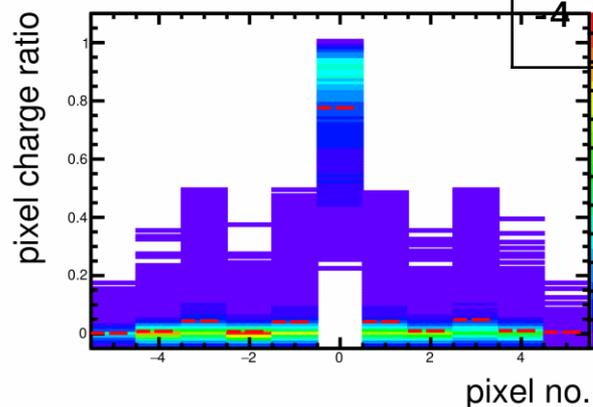
accumulated charge - Highest N pixel



CE65_4 Cluster size



CE65_4 Cluster charge distribution by ratio



2	3	4
-1	0	1
-4	-3	-2

WORK IN PROGRESS

Mean

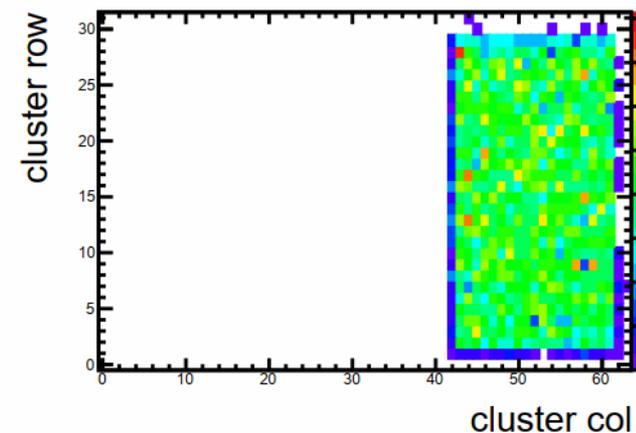


0.6%	4%	0.6%
4%	78%	4%
0.6%	4%	0.6%



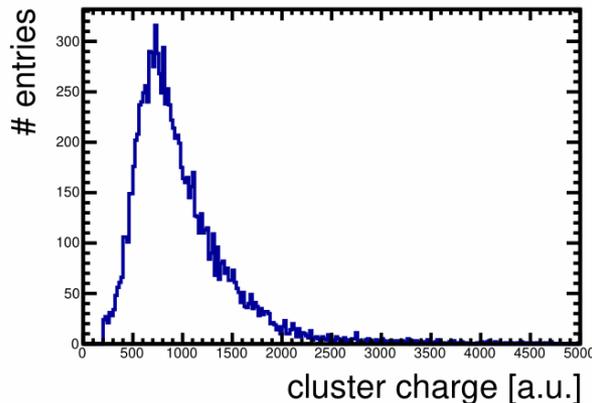
- B4 HV=10V, PSUB=0V
- Sub-matrix: AC amp.
 - Seeding
 - seed SNR > 2
 - cluster charge > 1000
 - method: sum3x3
 - Sensor edge: 2 pixel

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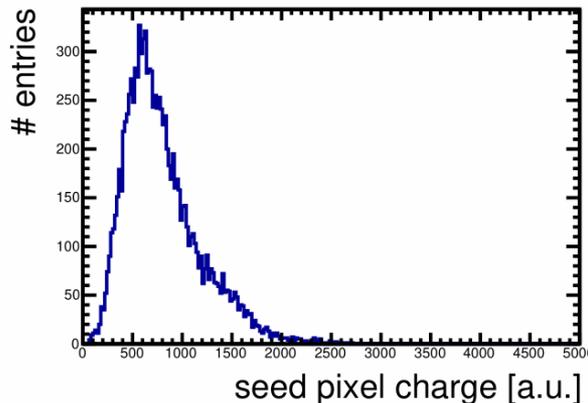


WORK IN PROGRESS

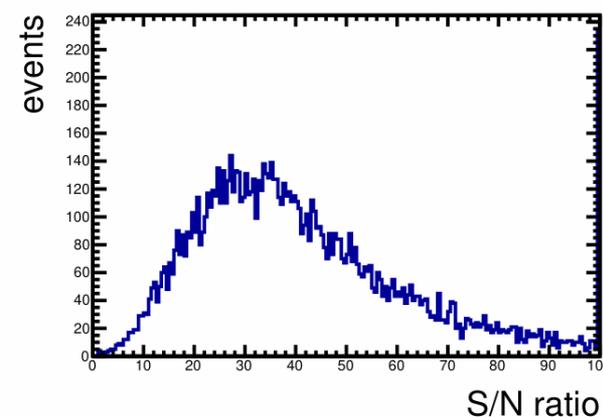
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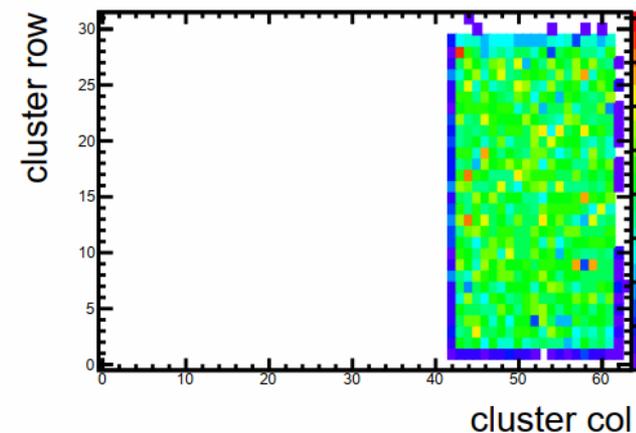
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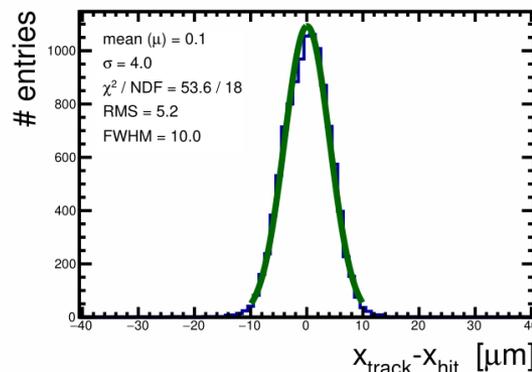
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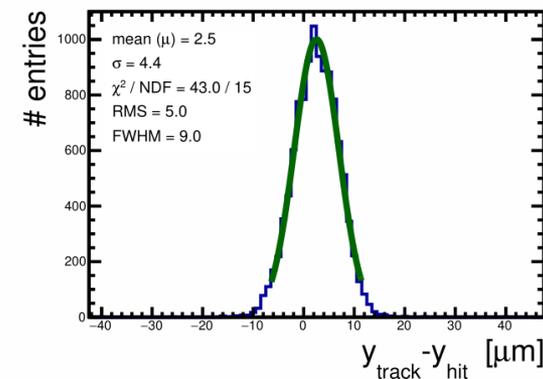


WORK IN PROGRESS

Residual in global X



Residual in global Y





ALICE



Analysis

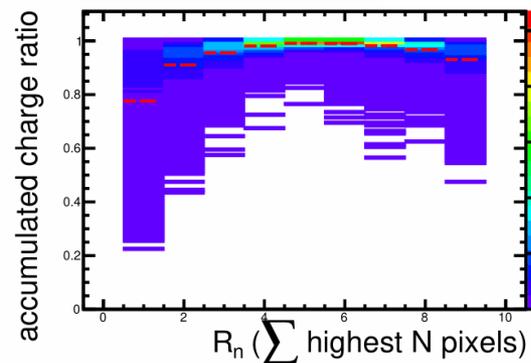
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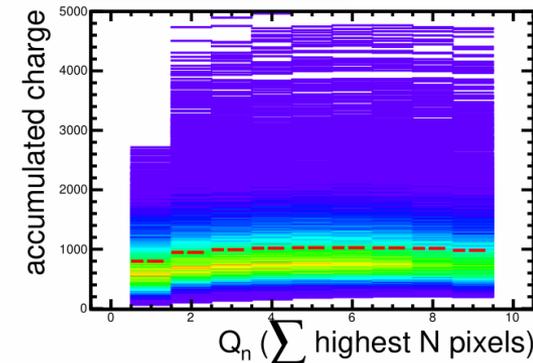


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 - Sub-matrix: SF
- Cluster shape
 - count all neighbours
 - ratio = $\frac{px. charge}{max. charge}$

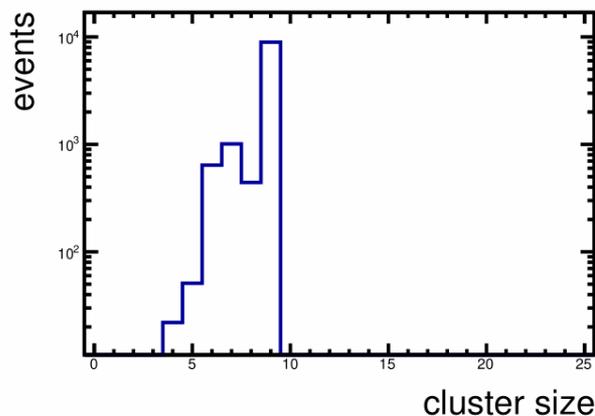
CE65_4 Cluster total charge ratio in N pixels



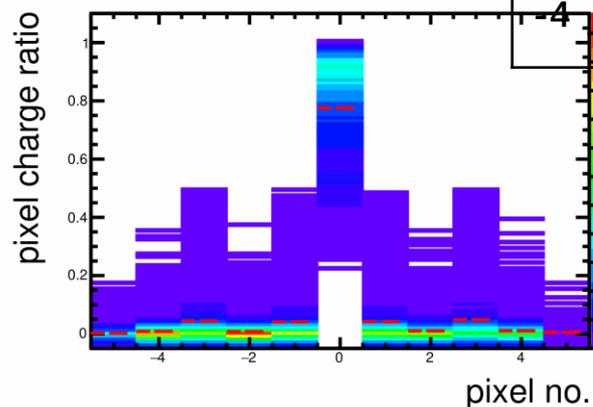
accumulated charge - Highest N pixel



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WORK IN PROGRESS

Mean



0.6%	4%	0.6%
4%	78%	4%
0.6%	4%	0.6%

- Landau-gaussian fitting for charge and SNR
- Analysis on CE65 D4 (pitch 25um)
- Preliminary plots for approval
 - Variants: B4 (AC/DC/SF), D4 (AC/DC/SF)
 - Variables: cluster charge, seed SNR, tracking residuals
 - Optional: accumulated charge/ Q_n , cluster shaperatio/ R_n



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Backup

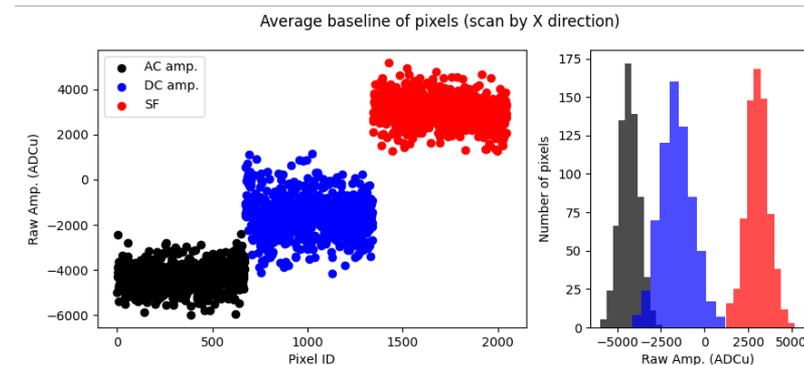
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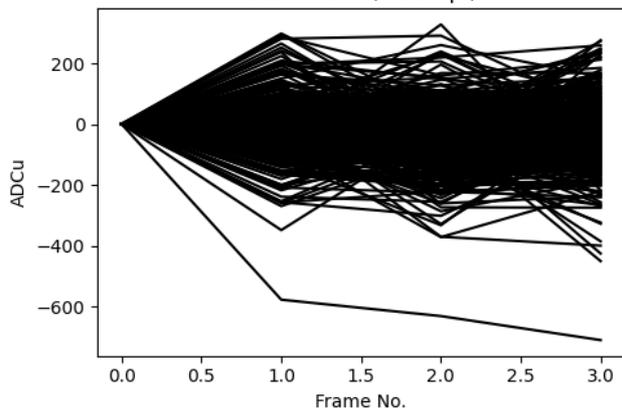
- Backup

- B4 HV=10V, PSUB=0V
 - Samples: 2+2 frames
 - Readout: 10 MHz
 - Time frame: 50us
- Raw amp. = $fr[-1] - fr[0]$

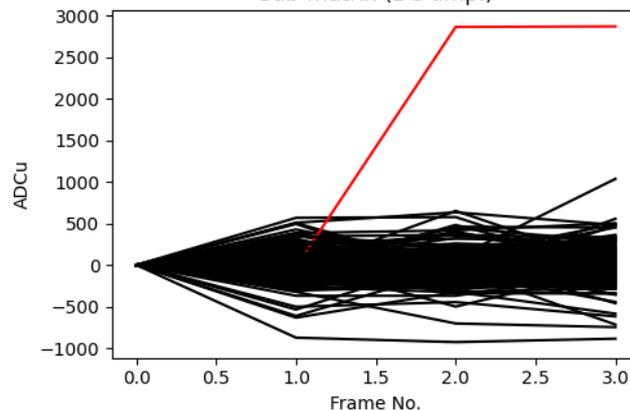


Analogue waveform (all pixels)

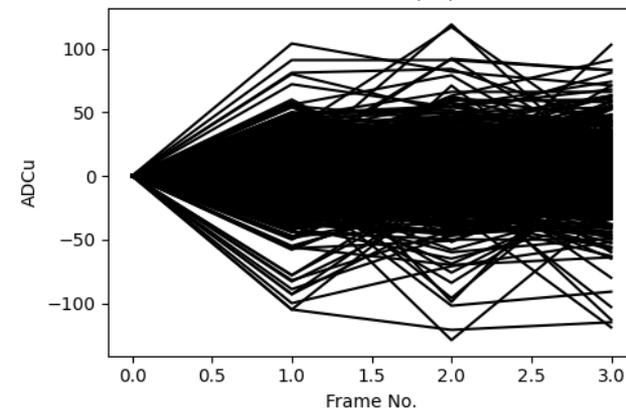
Sub-matrix (AC amp.)



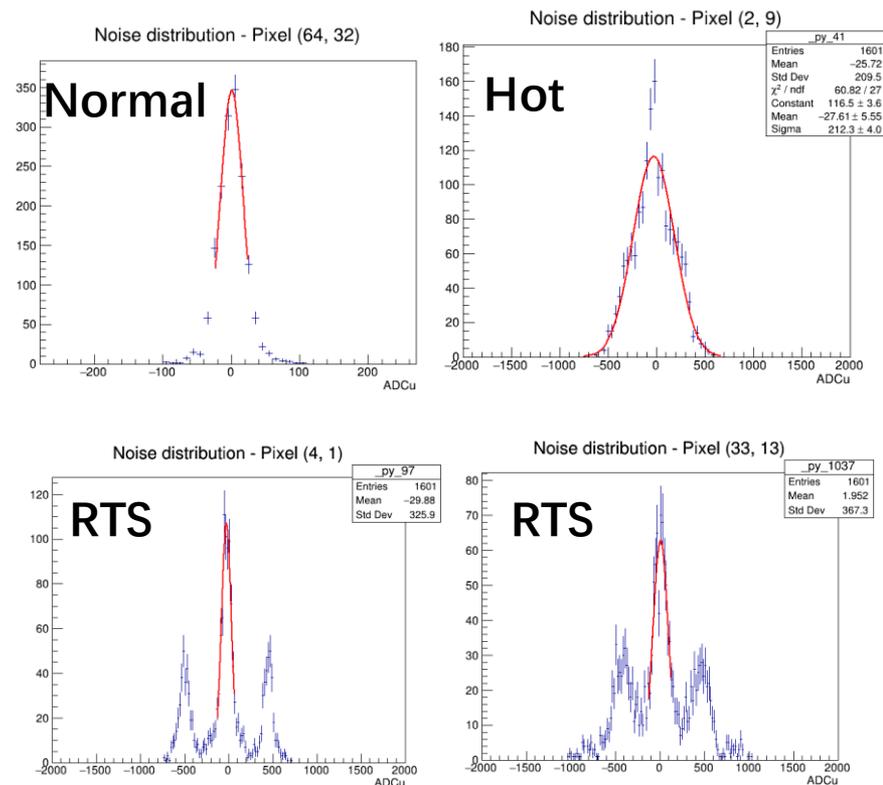
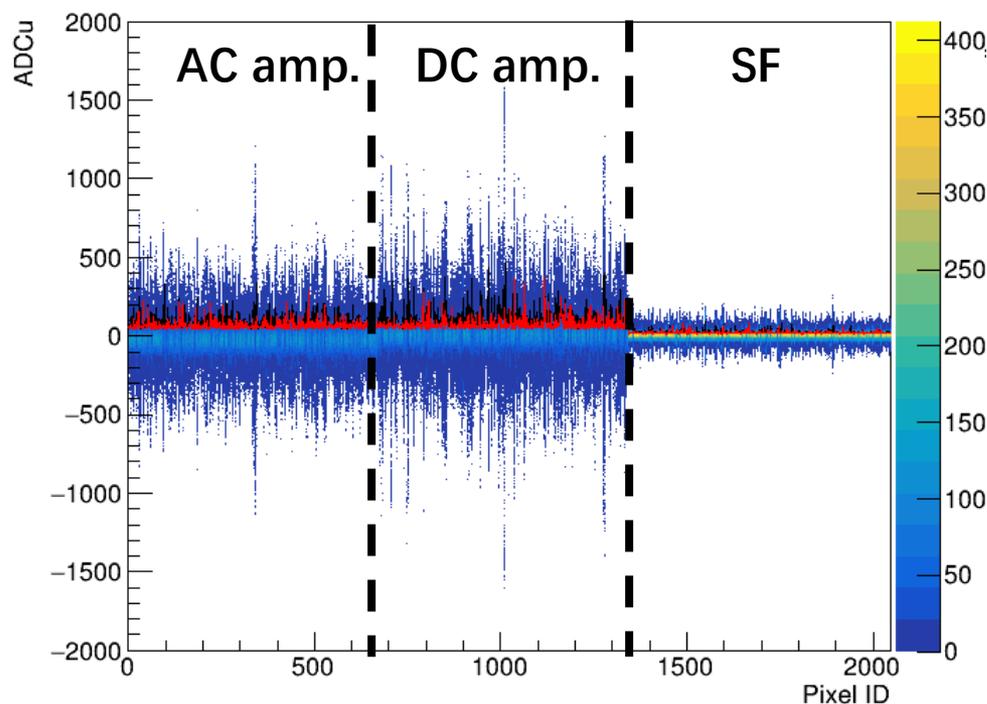
Sub-matrix (DC amp.)



Sub-matrix (SF)



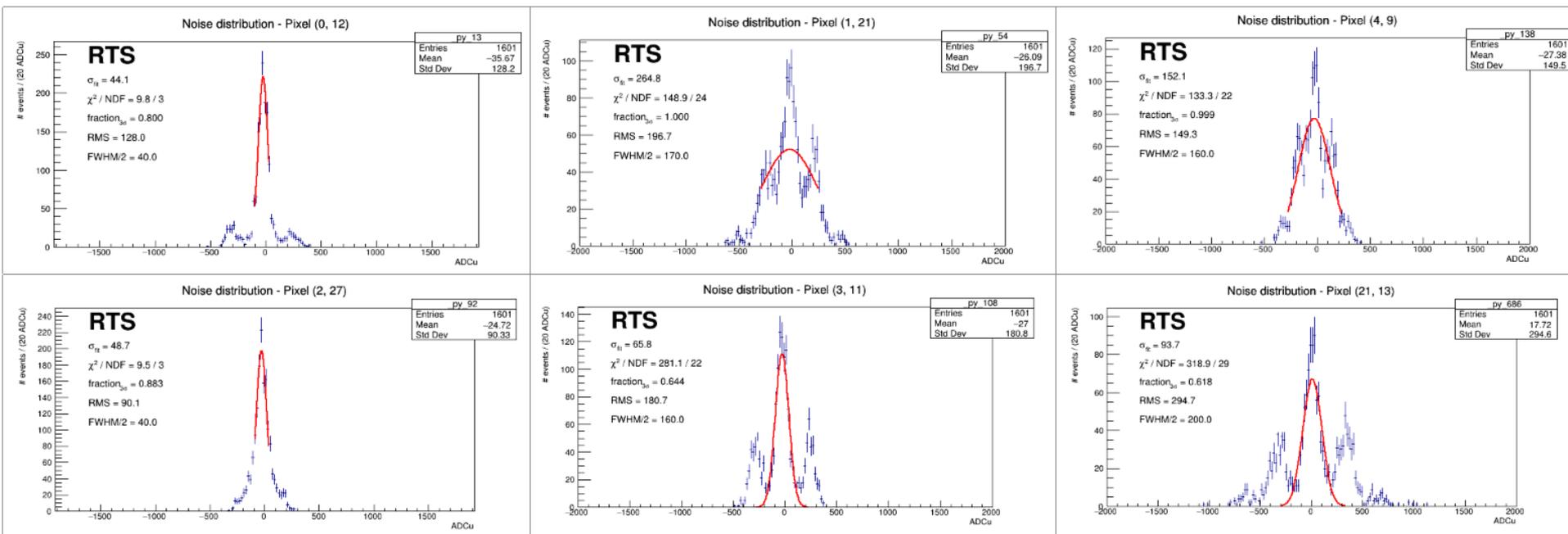
- B4 HV=10V, PSUB=0V
 - run187093307_220508093318.raw
 - Samples: 1601 events, 2+2 frames
 - Raw amp. = $fr[-1] - fr[0]$



RTS: random telegraph signal (burst noise)
Hot: noise > [200, 200, 30] (ADCu)

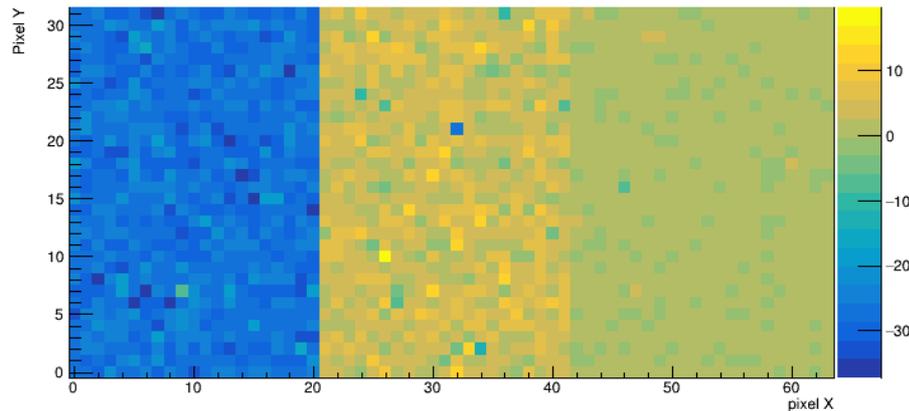
- B4 HV=10V, PSUB=0V
 - Dry-run: run187093307_220508093318.raw
 - Samples: 1601 events, 2+2 frames
 - Raw amp. = fr[-1] – fr[0]
- RTS tagging: $Fraction_{3\sigma} < 0.9$ or $\chi^2/ndf > 3$

Total pixels	2048
Normal	1715
RTS	269
Hot	64

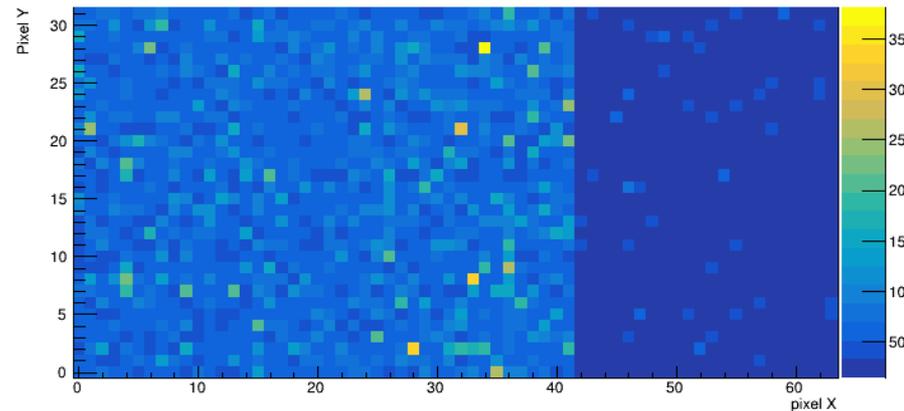


- B4 HV=10V, PSUB=0V
 - run187093307_220508093318.raw
 - Samples: 1601 events, 2+2 frames
 - Raw amp. = $fr[-1] - fr[0]$
- Generate pedestal and noise for each pixel
 - $Charge \equiv Raw\ amp. - pedestal$, $SNR \equiv Charge/noise$
- Mask pixels based on noise distribution (criteria TBD)

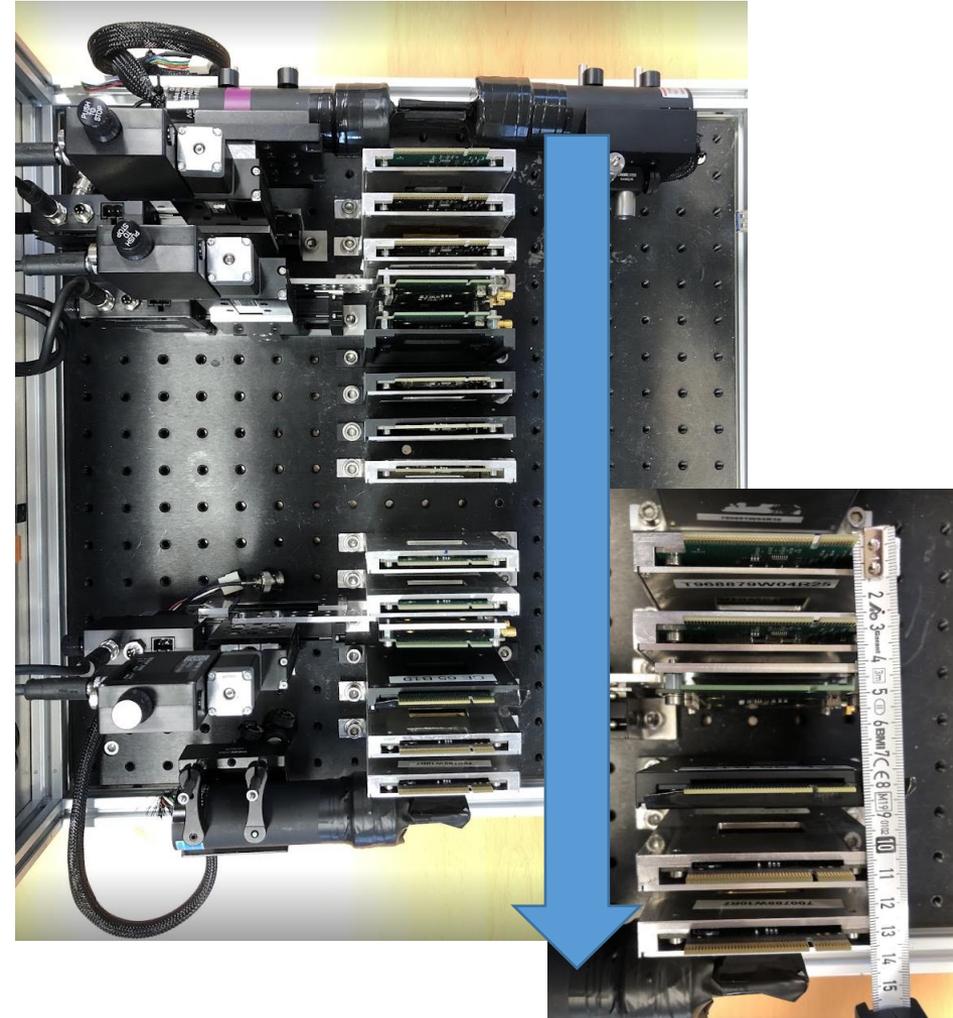
Map of pixel pedestal



Map of pixel noise amplitude

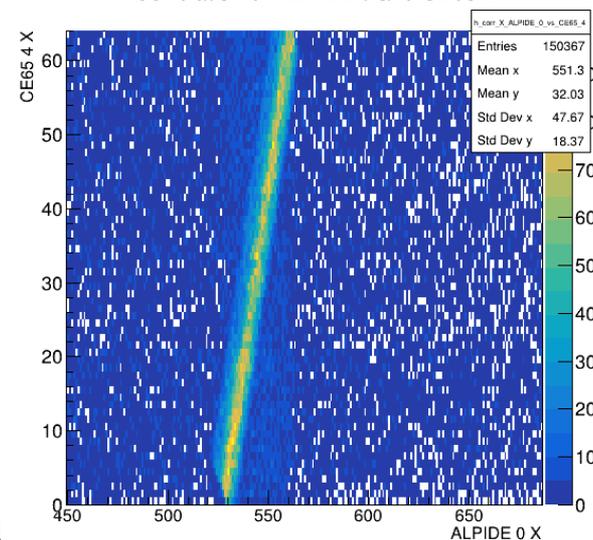


- CERN-PS T10 (2022 May.)
- Beam
 - Hadron (π^-) – 10 GeV
- Telescope
 - Trigger: Scintillators / **DPTS**
 - 2 REFS + DPTS + CE65 + 2REFS
- Data taking
 - May 4th – 24th
 - A4: HV=10V, 1, 2, 3, 4V
 - B4: HV=10V, 1, 2, 3, 4V
 - D4: HV=10V, 1, 2, 3, 4, 15V
 - C4: HV=10V, 1, 2, 3, 4V
 - PSUB=-3V, HV=0,1,2,3,4,10V

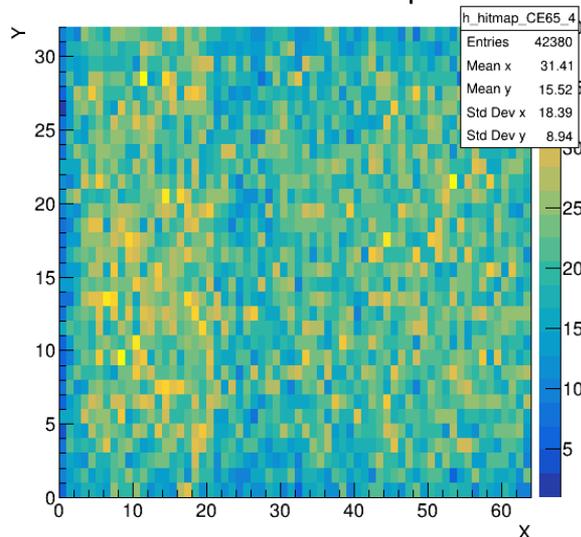


- B4 HV=10V
 - run187110733_220508110744.raw
 - Sample: 50k events
- **Data taking**
 - DPTS trigger scan from X:64 -> 0
 - > 10k tracks for each sub-matrix
- **Correlation with reference**

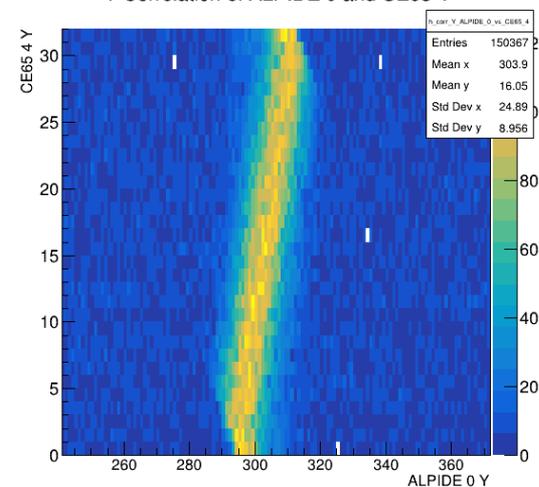
X Correlation of ALPIDE 0 and CE65 4



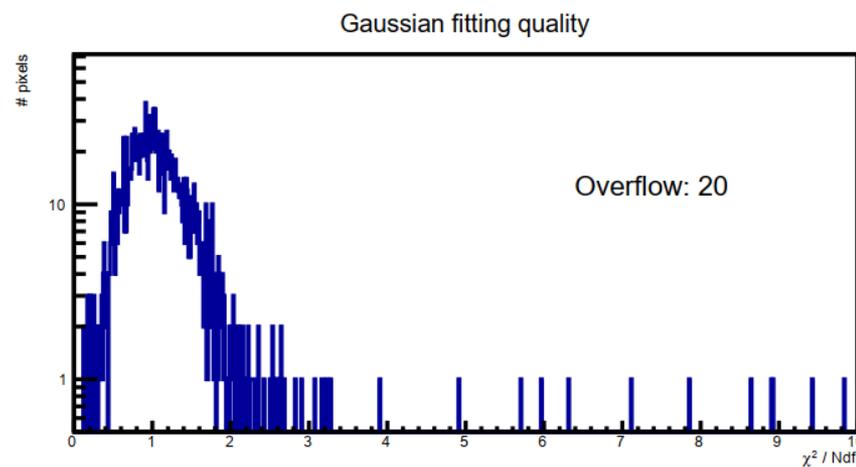
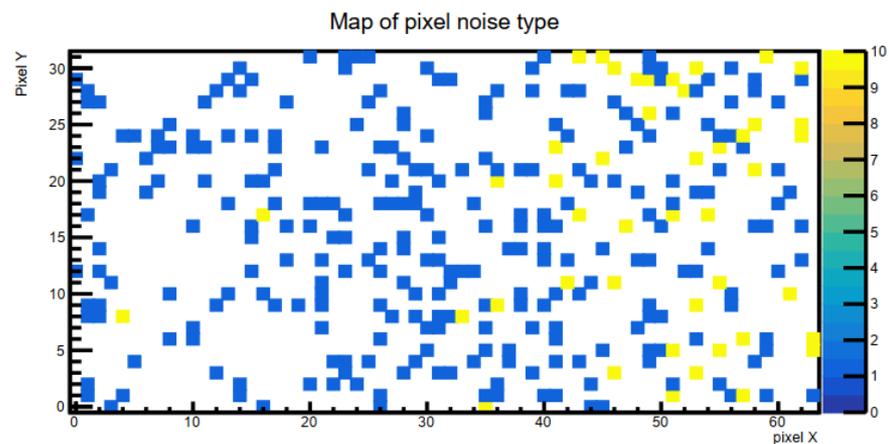
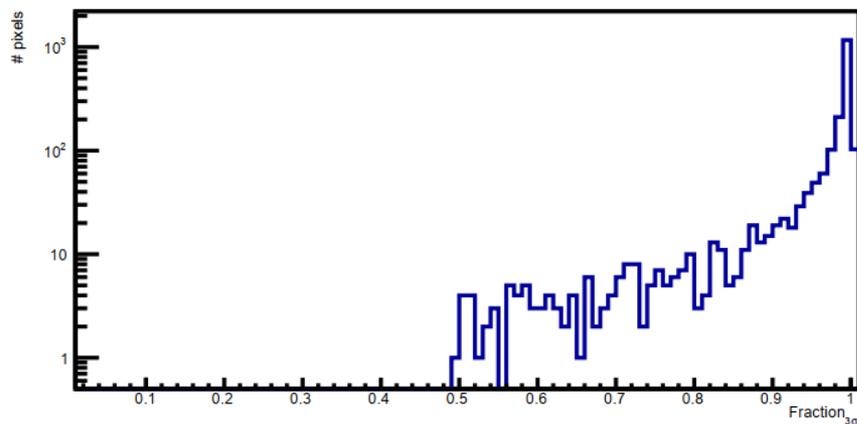
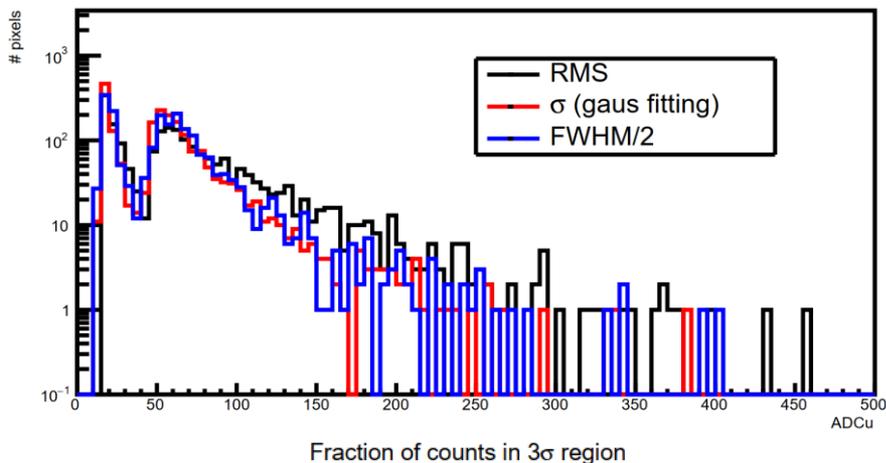
CE65 4 Raw Hitmap



Y Correlation of ALPIDE 0 and CE65 4



• Noise fitting





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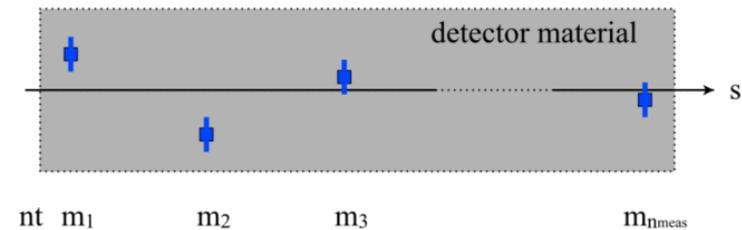
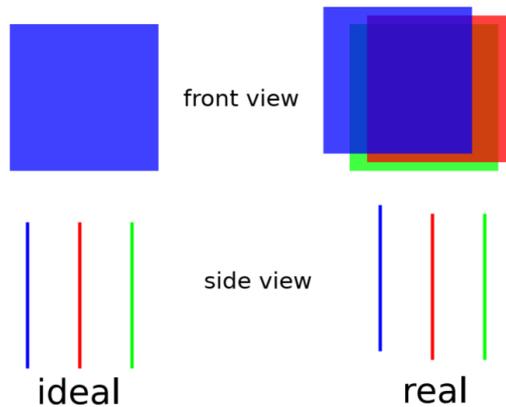
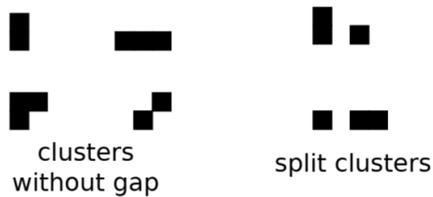
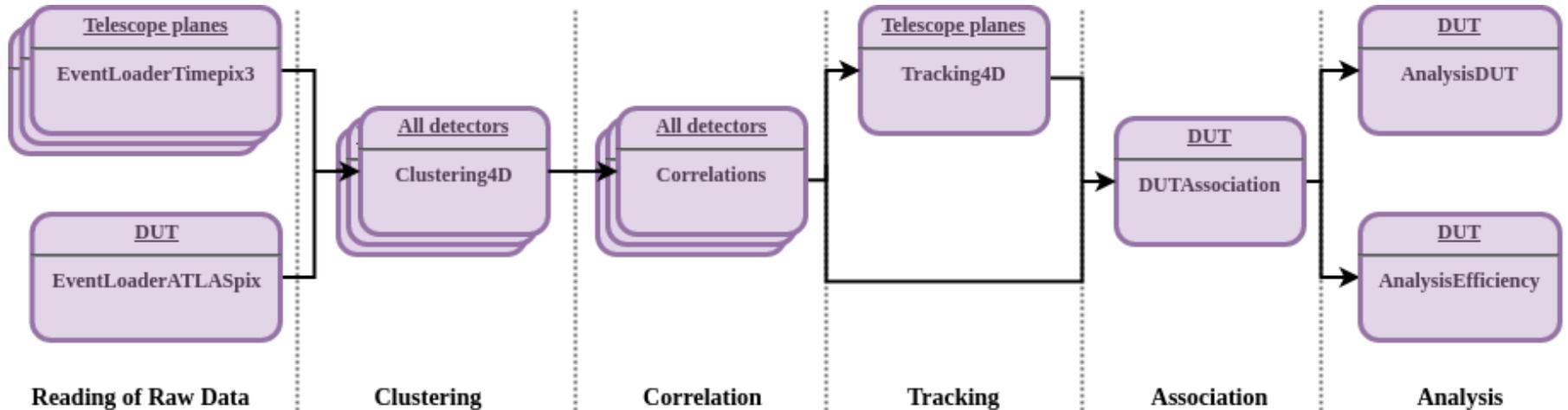
Analysis

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- Data analysis – corryvrekán



- Frequency in data taking of beam run

